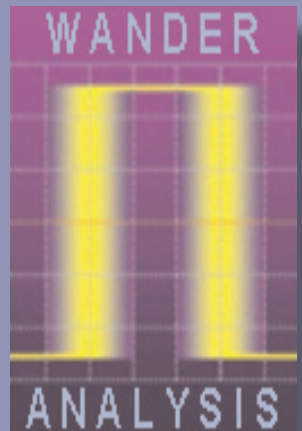


Wander Analysis Software

Supporting ONT, MTS and ANT Wander Solutions



Fast Wander Evaluation of TIE Data on Your PC

Free your ONT/MTS/ANT test instrument for real measurement tasks and comfortably do the TIE analysis at your desk.

Obtain your TIE data via LAN with a few keystrokes from your ONT/MTS/ANT. Benefit from the computing power of your local multi-core PC and shrink file load and computation times to a minimum. Even long-term measurement TIE data evaluation is now done in almost no time. Discover the advantages of markers, zoom, split display and high resolution graphics during your analysis work. Experience new evaluation types like fractional frequency offset (FFO) and drift rate (FFD) to obtain new insights in your system's behaviour. Drill down to interesting data sections or narrow the evaluation range to even further speed up evaluations. Choose from over 200 standard telecom masks or just define your own pass/fail masks by simply entering the math formula as given in the standards. Easily find out where a particular mask has been defined using our mask database reference information. Get a clear pass/fail indication with mask margins in graphical or tabular form. Improve your own documentation with copy and paste of displayed graphs and tables. Benefit from the experience of the market leader in Jitter/Wander test solutions and stay up-to-date with our free automatic web update service.

The JDSU "Wander Analysis Software" for PC offers a completely new professional working experience with wander TIE data processing. Don't get outdated, apply for a presentation now!

For further information please contact our local sales.

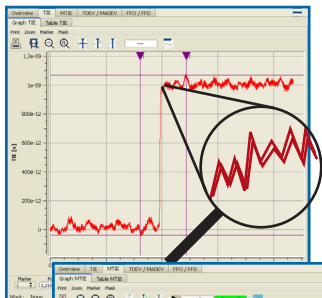


Features

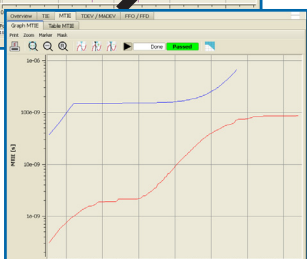
- Comprehensive analysis set
TIE/MTIE/TDEV/FFO/FFD
- Rich evaluation capabilities
 - Graphical & tabular display
 - Zooming, markers
 - Block select & partial evaluation within blocks
 - Split/clone display views
 - Relative TIE/MTIE
- Support of over 200 Telecom standards result masks for all analysis types
- Copy and paste of graphs and tables to other PC applications
- Support of ANT/ONT/MTS proprietary data formats
- Import of CSV TIE data
- Evaluation of very large files
- Speed optimized for fast load and analysis
- Runs on PCs with 32 or 64-bit OS (Windows 7, Vista, XP, Linux*) and MAC*
- Graphical result printout

*on request, consult factory

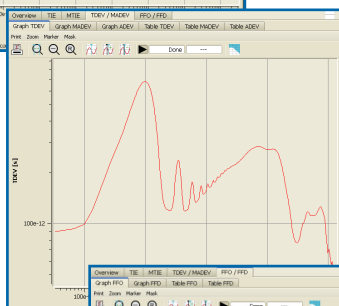
Wander Analysis Software



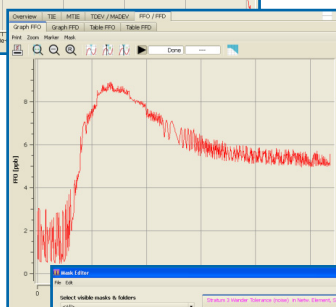
1. Discover TIE phase discontinuities, set markers, zoom in for details, set ranges for partial evaluation.



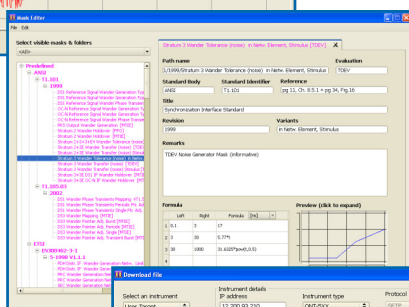
2. Calculate MTIE and compare against masks, export graphical results to other PC applications.



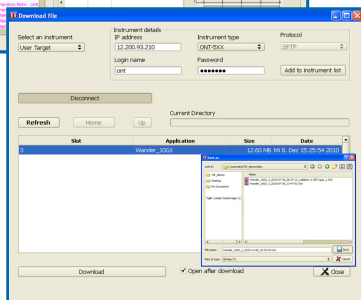
3. Check TDEV for spectral anomalies e.g. PLL oscillations.



4. Watch your IEEE 1588 slaves sync to their grandmaster with Frac. Freq. offset analysis.



5. Select your TIE/MTIE/TDEV/ FFO mask from over 200 telecom standard masks or simply create your own user mask



6. Download your TIE data directly from an ONT test instrument to your local disk and load it for further evaluation in almost no time

Order information

Wander Analysis Software for PC
BN 3061/95.98



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